

Search Notes

Application/Control No.

10/056,821

Examiner

Susan Y. Chen

Applicant(s)/Patent under
Reexamination

KEE ET AL.

Art Unit

2161

SEARCHED

| Class | Subclass | Date | Examiner |
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INTERFERENCE SEARCHED

| Class | Subclass | Date | Examiner |
|-------|----------|----------|----------|
| 707 | 10, 103X | 6/7/2006 | TYC |
| 707 | 200,201 | 6/7/2006 | TYC |
| 709 | 223 | 6/7/2006 | TYC |
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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

| | DATE | EXMR |
|---|----------|------|
| Updated text search on East DB | 6/7/2006 | TYC |
| NPL-Google, IEEE, ACM search | 6/6/2006 | TYC |
| STIC database search | 6/7/2006 | TYC |
| Consults with primary examiner - Wen. T. Lin at 709 for class crossreference | 6/7/2006 | TYC |
| Interference history search attached | 6/8/2006 | TYC |
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